JC20 Rec'd PCT/PTO 3 0 SEP 2005

Sheet 1 of 1

Form PTO-1449 US Dept. of Com (REV. 8-83) PATENT & TRADEMARK OF INFORMATION DISCLOSURE STATEMENT				ATTY DOCKET NO. 125471		1	APPLICATION NO. New U.S. National Stage of OT/19/19/19/19 02			
(Use several sheets if necessary)					APPLICANTS Satoshi SUGAHARA et al.					
					FILING DATE September 30, 2003 12/02/2005					
U.S. PATENT DOCUMENTS										
EXAMINER INITIAL		DOCUMENT NUMBER		DATE	NAM	NAME			SUB CLASS	
	 									
	 									
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FOREIGN PATENT DOCUMENTS										
		DOCUMENT NUMBER		DATE	COUNTRY			CLASS	SUB CLASS	
/J.V./	1)	JP A 11-238924 w/ abstract & trans	08/31/1999		JAPAN					
/J.V./	2)	JP A 2001-250998 w/ abst. & trans	09/14/2001		JAPAN					
/J.V./	3)	JP A 2003-78147 w/ abst. & trans	03/14/2003		JAPAN					
		OTHER POCH AS TO A			T					
	4)	OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.) LeClair et al., "Large Magnetoresistance using Hybrid Spin Filter Devices," Applied Physics Letters, Vol. 80, No. 4, pp.								
/J.V./		625-627, January 28, 2002	5-627, January 28, 2002							
	5)	Matsukura et al., "Control of Ferromagnetism in Filed-Effect Transistor of a Magnetic Semiconductor," Physica E, Vol. 12, pp. 351-355, 2002								
	6)	Sugawara et al., "Proposal of a Spin-Filter Transistor and its Application," 30a-ZH-1, No. 3, pp. 1566, March 27, 2003 with English translation								
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	9)	Inomata, "Present and Future of Magnetic RAM Technology," IEICE Trans. Electron., Vol. E84-C, No, 6, pp. 740-746, June 2001								
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EXAMINER	EXAMINER /Jami Valentine/ DATE CONSIDERED 05/30/2007									
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.										

Date: September 30, 2005